

Application/Control No.	Applicant(s)/Patent under Reexamination KRISHNAN ET AL.	
09/264,756		
Examiner	Art Unit	
Dustin Nguyen	2154	

SEARCHED ·					
Class	Subclass	Date	Examiner		
717	148	6/29/2007	DN		
709	206	6/29/2007	DN		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
717	148, 166	6/29/2007	DN	
707	2,100,206	6/29/2007	DN	
718	1	6/29/2007	DN	
709	206	6/29/2007	DN	

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
updated EAST search, ACM, IEEE, goggle, inventor search, consult SPE and WQAS on 101 issue	6/29/2007	DN
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